

## SN888C

SLLSEI4 -SEPTEMBER 2013

# Bus-Polarity Correcting RS-485 Transceiver for E-Meters

Check for Samples: SN888C

## **FEATURES**

- Exceeds Requirements of EIA-485 Standard
- Bus-Polarity Correction within 76 ms
- Data Rate: 300 bps to 250 kbps
- Works with Two Configurations:
  - Failsafe Resistors Only
  - Failsafe and Termination Resistors
- Up to 256 Nodes on a Bus
- SOIC-8 Package for Backward Compatibility
- Bus-Pin Protection:
  - ±16 kV HBM protection
  - ±12 kV IEC61000-4-2 Contact Discharge
  - +4 kV IEC61000-4-4 Fast Transient Burst

## APPLICATIONS

• E-meters

## DESCRIPTION

The SN888C is a low-power RS-485 transceiver with bus-polarity correction and transient protection. Upon hot plug-in the device detects and corrects the bus polarity within the first 76 ms of bus idling. On-chip transient protection protects the device against IEC61000 ESD and EFT transients.

The SN888C is available in an SOIC-8 package. The device is characterized from  $-40^{\circ}$ C to  $85^{\circ}$ C.

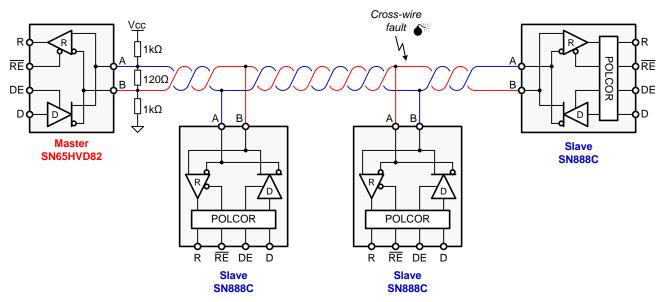


Figure 1. Typical Network Application With Polarity Correction (POLCOR)



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

## SN888C

SLLSEI4 -SEPTEMBER 2013

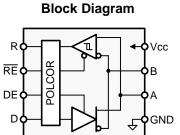


#### www.ti.com



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

SOIC-8 (TOP VIEW)						
	1● 2	7	∏ Vcc ∏ B			
	3	6 5	]] A ]] GND			
DE	4	Э	ш бир			



#### DRIVER PIN FUNCTIONS

INPUT	ENABLE	OUT	PUTS	DESCRIPTION
D	DE	Α	В	DESCRIPTION
				NORMAL MODE
Н	Н	Н	L	Actively drives bus high
L	Н	L	Н	Actively drives bus low
Х	L	Z	Z	Driver disabled
Х	OPEN	Z	Z	Driver disabled by default
OPEN	Н	Н	L	Actively drives bus high
				POLARITY-CORRECTING MODE <sup>(1)</sup>
Н	Н	L	Н	Actively drives bus low
L	Н	Н	L	Actively drives bus high
Х	L	Z	Z	Driver disabled
Х	OPEN	Z	Z	Driver disabled by default
OPEN	Н	L	Н	Actively drives bus low

(1) The polarity-correcting mode is entered when  $V_{ID} < V_{IT-}$  and  $t > t_{FS}$  and DE = low. This state is latched when /RE turns from low to high.

#### **RECEIVER PIN FUNCTIONS**

DIFFERENTIAL INPUT	ENABLE	OUTPUT	DESCRIPTION
$V_{ID} = V_A - V_B$	/RE	R	
			NORMAL MODE
$V_{IT+} < V_{ID}$	L	Н	Receive valid bus high
$V_{\rm IT-} < V_{\rm ID} < V_{\rm IT+}$	L	?	Indeterminate bus state
$V_{ID} < V_{IT-}$	L	L	Receive valid bus low
Х	Н	Z	Receiver disabled
Х	OPEN	Z	Receiver disabled
Open, short, idle bus	L	?	Indeterminate bus state
		POL	ARITY-CORRECTING MODE <sup>(1)</sup>
$V_{IT+} < V_{ID}$	L	L	Receive valid bus low
$V_{IT-} < V_{ID} < V_{IT+}$	L	?	Indeterminate bus state
$V_{ID} < V_{IT-}$	L	Н	Receive polarity corrected bus high
Х	Н	Z	Receiver disabled
Х	OPEN	Z	Receiver disabled
Open, short, idle bus	L	?	Indeterminate bus state

(1) The polarity-correcting mode is entered when  $V_{ID} < V_{IT-}$  and t > t<sub>FS</sub> and DE = low. This state is latched when /RE turns from low to high.

### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

			VALUE		UNIT
			MIN	MAX	
V <sub>CC</sub>	Supply voltage		-0.5	7	
	Input voltage range at any I	ogic pin	-0.3	5.7	N/
	Voltage input range, transie	ent pulse, A and B, through 100 $\Omega$	-100	100	V
	Voltage range at A or B inp	uts	-18	18	
	Receiver output current		-24	24	mA
	Continuous total-power diss	sipation	See THERMAL INFORMATION tab		ON table
	IEC 61000-4-2 ESD (Conta	ct Discharge), bus terminals and GND		±12	
	IEC 61000-4-4 EFT (Fast tr	ansient or burst) bus terminals and GND		±4	
	IEC 60749-26 ESD (HBM),	bus terminals and GND		±16	kV
		Test Method A114 (HBM), all pins		±8	
	JEDEC Standard 22	Test Method C101 (Charged Device Model), all pins		±1.5	
		Test Method A115 (Machine Model), all pins		±200	V
TJ	Junction temperature			170	**
T <sub>STG</sub>	Storage temperature		-65	150	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### THERMAL INFORMATION

		SN888C	
	THERMAL METRIC <sup>(1)</sup>	PACKAGE SOIC (D)	UNITS
$\theta_{JA}$	Junction-to-ambient thermal resistance	116.1	
θ <sub>JCtop</sub>	Junction-to-case (top) thermal resistance	60.8	
$\theta_{JB}$	Junction-to-board thermal resistance <sup>(2)</sup>	57.1	°C 111
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	13.9	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	56.5	
$\theta_{JCbot}$	Junction-to-case (bottom) thermal resistance	NA	

For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.
 The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.

#### POWER DISSIPATION

PARAMETER			TEST CONDITIONS	VALUE	UNITS
	Power dissipation	Unterminated	$\begin{array}{l} R_{L} = 300 \ \Omega, \\ C_{L} = 50 \ pF \ (driver) \end{array}$	164	
PD	Driver and receiver enabled, $V_{CC} = 5.5 \text{ V}, T_J = 150^{\circ}\text{C}$ 50% duty cycle square-wave signal at	RS-422 load	$R_L = 100 \Omega,$ $C_L = 50 \text{ pF} \text{ (driver)}$	247	mW
	250-kbps signaling rate:	RS-485 load	$ \begin{array}{l} R_{L} = 54 \ \Omega, \\ C_{L} = 50 \ pF \ (driver) \end{array} $	316	



## **RECOMMENDED OPERATING CONDITIONS**

			MIN	NOM	MAX	UNIT
$V_{CC}$	Supply voltage		4.5	5	5.5	
$V_{\text{ID}}$	Differential input voltage		-12		12	
VI	Input voltage at any bus terminal (	separate or common mode) <sup>(1)</sup>	-7		12	V
$V_{\text{IH}}$	High-level input voltage (driver, dri	ver-enable, and receiver-enable inputs)	2		$V_{CC}$	
VIL	Low-level input voltage (driver, driv	ver-enable, and receiver-enable inputs)	0		0.8	
		Driver	-60		60	~
I <sub>O</sub>	Output current	Receiver	-8		8	mA
CL	Differential load capacitance			50		pF
RL	Differential load resistance			60		Ω
1/t <sub>UI</sub>	Signaling rate		0.3		250	kbps
TJ	Junction temperature		-40		150	
T <sub>A</sub> <sup>(2)</sup>	Operating free-air temperature (se information)	e THERMAL INFORMATION for additional	-40		85	°C

The algebraic convention in which the least positive (most negative) limit is designated as minimum is used in this data sheet.
 Operation is specified for internal (junction) temperatures up to 150°C. Self-heating due to internal power dissipation should be considered for each application. Maximum junction temperature is internally limited by the thermal shut-down (TSD) circuit which disables the driver outputs when the junction temperature reaches 170°C.

## **ELECTRICAL CHARACTERISTICS**

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
1.7.1	Driver differential-output	RL = 60 Ω, 375 Ω on each output from $-7$ to +12 V	See Figure 2	1.5	2.5		
V <sub>OD</sub>	voltage magnitude	RL = 54 Ω (RS-485)	See Figure 2	1.5	2.5		V
		RL = 100 Ω (RS-422)	— See Figure 3	2	3		
∆ V <sub>OD</sub> 	Change in magnitude of driver differential-output voltage	RL = 54 Ω, CL = 50 pF	See Figure 3	-0.2	0	0.2	V
V <sub>OC(SS)</sub>	Steady-state common-mode output voltage			1	V <sub>CC</sub> / 2	3	V
ΔV <sub>OC</sub>	Change in differential driver common-mode output voltage	Center of two 27-Ω load resistors	See Figure 3	-0.2	0	0.2	mV
V <sub>OC(PP)</sub>	Peak-to-peak driver common- mode output voltage				850		
C <sub>OD</sub>	Differential output capacitance				8		pF
V <sub>IT+</sub>	Positive-going receiver differential-input voltage threshold				35	100	mV
V <sub>IT-</sub>	Negative-going receiver differential-input voltage threshold			-100	-35		mV
V <sub>HYS</sub> <sup>(1)</sup>	Receiver differential-input voltage threshold hysteresis $(V_{IT+} - V_{IT-})$			40	60		mV
V <sub>OH</sub>	Receiver high-level output voltage	I <sub>OH</sub> = -8 mA		2.4	V <sub>CC</sub> – 0.3		V
V <sub>OL</sub>	Receiver low-level output voltage	I <sub>OL</sub> = 8 mA			0.2	0.4	V
lı	Driver input, driver enable, and receiver enable input current			-2		2	μA

(1) Under any specific conditions,  $V_{\text{IT+}}$  is ensured to be at least  $V_{\text{HYS}}$  higher than  $V_{\text{IT-}}$ 

## **ELECTRICAL CHARACTERISTICS (continued)**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER TEST CONDITIONS		MIN	TYP	MAX	UNIT		
I <sub>OZ</sub>	Receiver high-impedance output current	VO = 0 V or VCC, /RE at VCC		-10		10	μA	
I <sub>OS</sub>	Driver short-circuit output current	$ I_{OS} $ with V <sub>A</sub> or V <sub>B</sub> from –7 to	$ I_{OS} $ with V <sub>A</sub> or V <sub>B</sub> from –7 to +12 V			150	mA	
	Bus input current (driver	$V_{CC}$ = 4.5 to 5.5 V or	V <sub>I</sub> = 12 V		75	125		
IJ	disabled)	$V_{CC}$ = 0 V, DE at 0 V	$V_1 = -7 V$	-100	-40		μΑ	
		Driver and receiver enabled	DE = V <sub>CC</sub> , /RE = GND, No load		750	900		
		Driver enabled, receiver disabled	eq:def-def-def-def-def-def-def-def-def-def-			650		
I <sub>CC</sub>	CC Supply current (quiescent)	Driver disabled, receiver enabled	DE = GND, /RE = GND, No load			750	μA	
		Driver and receiver disabled	DE = GND, D = GND /RE = VCC, No load		0.4	5		
	Supply current (dynamic)	See						

### SWITCHING CHARACTERISTICS

3.3 ms > bit time > 4  $\mu$ s (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
DRIVER							
t <sub>r</sub> , t <sub>f</sub>	Driver differential-output rise and fall times	RL = 54 Ω, CL = 50	PL - 54 0, 0L - 50		700	1200	
t <sub>PHL</sub> , t <sub>PLH</sub>	Driver propagation delay	pF	See Figure 4	90	700	1000	ns
t <sub>SK(P)</sub>	Driver pulse skew,  t <sub>PHL</sub> – t <sub>PLH</sub>				25	200	
t <sub>PHZ</sub> , t <sub>PLZ</sub>	Driver disable time				50	500	
t <sub>PHZ</sub> , t <sub>PLZ</sub>	Driver enable time	Receiver enabled	See Figure 5 and Figure 6		500	1000	ns
		Receiver disabled	l iguie e		3	9	μs
RECEIVER	2	•					
t <sub>r</sub> , t <sub>f</sub>	Receiver output rise and fall times				18	30	
t <sub>PHL</sub> , t <sub>PLH</sub>	Receiver propagation delay time	CL = 15 pF	See Figure 7		85	195	ns
t <sub>SK(P)</sub>	Receiver pulse skew,  t <sub>PHL</sub> - t <sub>PLH</sub>				1	15	
t <sub>PHZ</sub> , t <sub>PLZ</sub>	Receiver disable time				50	500	
t <sub>PZL(1)</sub> ,		Driver enabled	See Figure 8		20	130	ns
$t_{PZH(1)}$ $t_{PZL(2)}$ , $t_{PZH(2)}$	Receiver enable time	Driver disabled	See Figure 9		2	8	μs
t <sub>FS</sub>	Bus failsafe time	Driver disabled	See Figure 10	44	58	76	ms

TEXAS INSTRUMENTS

www.ti.com

SLLSEI4 - SEPTEMBER 2013

#### PARAMETER MEASUREMENT INFORMATION

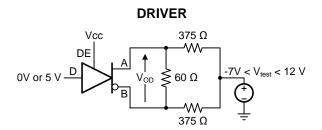


Figure 2. Measurement of Driver Differential-Output Voltage With Common-Mode Load

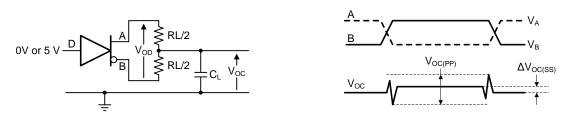


Figure 3. Measurement of Driver Differential and Common-Mode Output With RS-485 Load

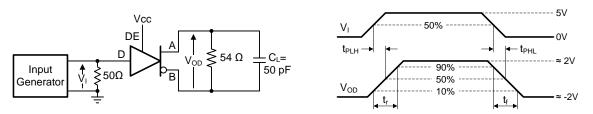


Figure 4. Measurement of Driver Differential-Output Rise and Fall Times and Propagation Delays

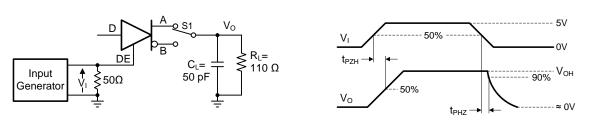


Figure 5. Measurement of Driver Enable and Disable Times With Active-High Output and Pull-Down Load

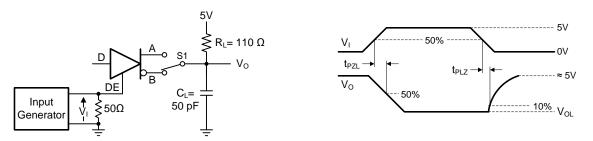


Figure 6. Measurement of Driver Enable and Disable Times With Active-Low Output and Pull-Up Load

6



SLLSEI4 -SEPTEMBER 2013

### PARAMETER MEASUREMENT INFORMATION (continued)

#### RECEIVER

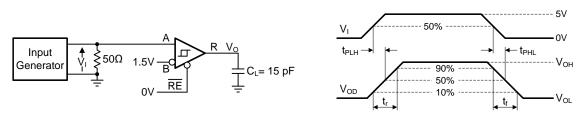


Figure 7. Measurement of Receiver Output Rise and Fall Times and Propagation Delays

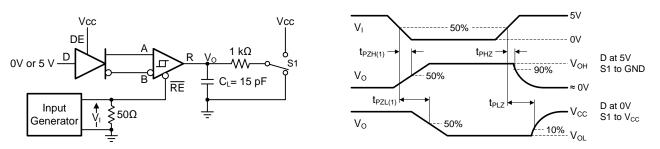


Figure 8. Measurement of Receiver Enable and Disable Times With Driver Enabled

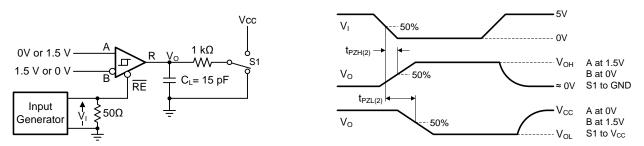


Figure 9. Measurement of Receiver Enable Times With Driver Disabled

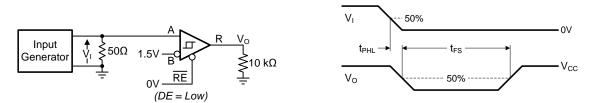


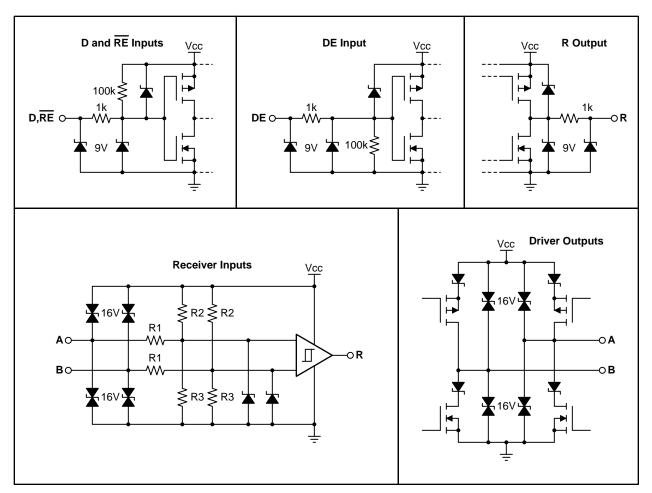
Figure 10. Measurement of Receiver Polarity-Correction Time With Driver Disabled



SLLSEI4 -SEPTEMBER 2013

www.ti.com







## **DEVICE INFORMATION**

#### Low-Power Standby Mode

When the driver and the receiver are both disabled (DE = low and RE = high) the device enters standby mode. If the enable inputs are in the disabled state for only a brief time (for example: less than 100 ns), the device does not enter standby mode, preventing the SN888C device from entering standby mode during driver or receiver enabling. Only when the enable inputs are held in the disabled state for a duration of 300 ns or more does the device enter low-power standby mode. In this mode most internal circuitry is powered down, and the steady-state supply current is typically less than 400 nA. When either the driver or the receiver is re-enabled, the internal circuitry becomes active. During  $V_{CC}$  power-up, when the device is set for both driver and receiver disabled mode, the device may consume more than 5-µA of ICC disabled current because of capacitance charging effects. This condition occurs only during  $V_{CC}$  power-up.

### **Bus Polarity Correction**

The SN888C device automatically corrects a wrong bus-signal polarity caused by a cross-wire fault. In order to detect the bus polarity, all three of the following conditions must be met:

- A failsafe-biasing network (commonly at the master node) must define the signal polarity of the bus.
- A slave node must enable the receiver and disable the driver (/RE = DE = low).
- The bus must idle for the failsafe time, t<sub>FS-max</sub>.

After the failsafe time has passed, the polarity correction is complete and applied to both the receive and transmit channels. The status of the bus polarity latches within the transceiver and maintains for subsequent data transmissions.

#### NOTE

Avoid data string durations of consecutive 0s or 1s exceeding  $t_{FS-min}$ , which can accidently trigger a wrong polarity correction.

Figure 11 shows a simple point-to-point data link between a master node and a slave node. Because the master node with the failsafe biasing network determines the signal polarity on the bus, an RS-485 transceiver without polarity correction, such as SN65HVD82, suffices. All other bus nodes, typically performing as slaves, require the SN888C transceiver with polarity correction.

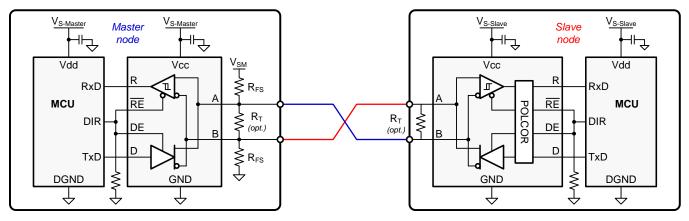


Figure 11. Point-To-Point Data Link With Cross-Wire Fault

Prior to initiating data transmission the master transceiver must idle for a time span that exceeds the maximum failsafe time,  $t_{FS-max}$ , of a slave transceiver. To accomplish this idle time, drive the direction control line, DIR, low. After a time,  $t > t_{FS-max}$ , the master begins transmitting data.

Because of the indicated cross-wire fault between master and slave, the slave node receives bus signals with reversed polarity. Assuming the slave node has just been connected to the bus, the direction-control pin is pulled-down during power-up, and then is actively driven low by the slave MCU. The polarity correction begins as soon as the slave supply is established and ends after approximately 44 to 76 ms.

TEXAS INSTRUMENTS

www.ti.com

#### SLLSEI4 -SEPTEMBER 2013

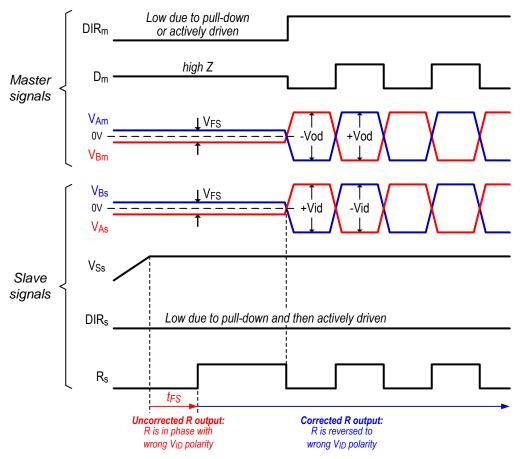


Figure 12. Polarity Correction Timing Prior to a Data Transmission

Initially the slave receiver assumes that the correct bus polarity is applied to the inputs and performs no polarity reversal. Because of the reversed polarity of the bus-failsafe voltage, the output of the slave receiver,  $R_S$ , turns low. After  $t_{FS}$  has passed and the receiver has detected the wrong bus polarity, the internal POLCOR logic reverses the input signal and  $R_S$  turns high.

At this point, all incoming bus data with reversed polarity are polarity-corrected within the transceiver. Because polarity correction is also applied to the transmit path, the data sent by the slave MCU are reversed by the POLCOR logic, then fed into the driver.

The reversed data from the slave MCU are reversed again by the cross-wire fault in the bus, and the correct bus polarity is reestablished at the master end.

This process repeats each time the device powers up and detects an incorrect bus polarity.



SLLSEI4 -SEPTEMBER 2013

www.ti.com

## **APPLICATION INFORMATION**

### **Device Configuration**

The SN888C device is a half-duplex RS-485 transceiver operating from a single 5-V  $\pm$ 10% supply. The driver and receiver enable pins that allow for the configuration of different operating modes.

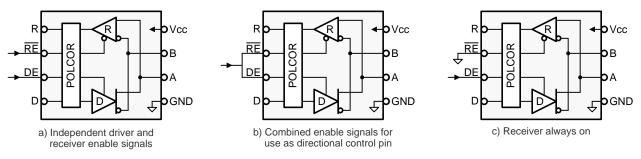


Figure 13. Transceiver Configurations

Using independent enable lines provides the most flexible control as the lines allow for the driver and the receiver to be turned on and off individually. While this configuration requires two control lines, it allows for selective listening to the bus traffic, whether the driver is transmitting data or not. Only this configuration allows the SN888C device to enter low-power standby mode because it allows both the driver and receiver to be disabled simultaneously.

Combining the enable signals simplifies the interface to the controller by forming a single direction-control signal. Thus, when the direction-control line is high, the transceiver is configured as a driver, while when low, the device operates as a receiver.

Tying the receiver enable to ground and controlling only the driver-enable input also uses only one control line. In this configuration, a node not only receives the data on the bus sent by other nodes, but also receives the data sent on the bus, enabling the node to verify the correct data has been transmitted.

### Bus Design

An RS-485 bus consists of multiple transceivers connected in parallel to a bus cable. To eliminate line reflections, each cable end is terminated with a termination resistor, RT, whose value matches the characteristic impedance, Z0, of the cable. This method, known as parallel termination, allows for relatively high data rates over long cable length.

Common cables used are unshielded twisted pair (UTP), such as low-cost CAT-5 cable with Z0 = 100  $\Omega$ , and RS-485 cable with Z0 = 120  $\Omega$ . Typical cable sizes are AWG 22 and AWG 24.

The maximum bus length is typically given as 4000 ft or 1200 m, and represents the length of an AWG 24 cable whose cable resistance approaches the value of the termination resistance, thus reducing the bus signal by half or 6 dB. Actual maximum usable cable length depends on the signaling rate, cable characteristics, and environmental conditions.

V <sub>cc</sub>	R <sub>L</sub> Differential Termination	R <sub>FS</sub> Pull-Up	R <sub>FS</sub> Pull-Down	V <sub>ID</sub>
		560 Ω	560 Ω	230 mV
5 V	54 Ω	1 ΚΩ	1 ΚΩ	131 mV
υ	54 \\2	4.7 ΚΩ	4.7 ΚΩ	29 mV
		10 KΩ	10 KΩ	13 mV

 Table 1. VID With a Failsafe Network and Bus Termination

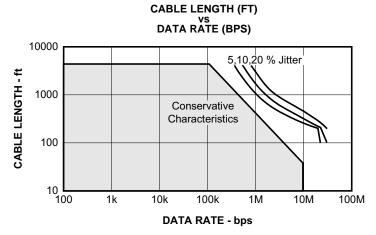
An external failsafe-resistor network must be used to ensure failsafe operation during an idle bus state. When the bus is not actively driven, the differential receiver inputs could float allowing the receiver output to assume a random output. A proper failsafe network forces the receiver inputs to exceed the VIT threshold, thus forcing the SN888C receiver output into the failsafe (high) state. Table 1 shows the differential input voltage ( $V_{ID}$ ) for various failsafe networks with a 54- $\Omega$  differential bus termination.

Copyright © 2013, Texas Instruments Incorporated

#### SLLSEI4 -SEPTEMBER 2013

## Cable Length Versus Data Rate

There is an inverse relationship between data rate and cable length, which means the higher the data rate, the shorter the cable length; and conversely, the lower the data rate, the longer the cable length. While most RS-485 systems use data rates between 10 kbps and 100 kbps, applications such as e-metering often operate at rates of up to 250 kbps even at distances of 4000 ft and longer. Longer distances are possible by allowing for small signal jitter of up to 5 or 10%.



### Stub Length

When connecting a node to the bus, the distance between the transceiver inputs and the cable trunk, known as the stub, should be as short as possible. The reason for the short distance is because a stub presents a non-terminated piece of bus line, which can introduce reflections if the distance is too long. As a general guideline, the electrical length or round-trip delay of a stub should be less than one-tenth of the rise time of the driver, thus leading to a maximum physical stub length as shown in Equation 1.

 $L_{Stub} \le 0.1 \times t_r \times v \times c$ 

where

- $t_r$  is the 10 / 90 rise time of the driver
- c is the speed of light  $(3 \times 10^8 \text{ m/s or } 9.8 \times 10^8 \text{ ft/s})$
- v is the signal velocity of the cable (v = 78%) or trace (v = 45%) as a factor of c (1)

Based on Equation 1, with a minimum rise time of 400 ns, Equation 2 shows the maximum cable-stub length of the SN888C device.

 $L_{Stub} \le 0.1 \times 400 \times 10^{-9} \times 3 \times 10^8 \times 0.78 = 9,4 \text{ m} \text{ (or } 30.6 \text{ ft)}$ 

(2)

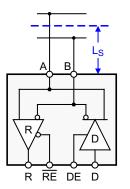


Figure 14. Stub Length



#### 3-V to 5-V Interface

Interfacing the SN888C device to a 3-V controller is easy. Because the 5-V logic inputs of the transceiver accept 3-V input signals, they can be directly connected to the controller I/O. The 5-V receiver output, R, however, must be level-shifted by a Schottky diode and a 10-k resistor to connect to the controller input (see Figure 15). When R is high, the diode is reverse biased and the controller supply potential lies at the controller RxD input. When R is low, the diode is forward biased and conducts. Only in this case, the diode forward voltage of 0.2 V lies at the controller RxD input.

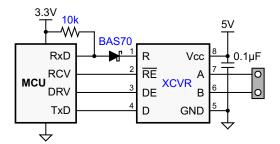


Figure 15. 3-V to 5-V Interface

#### Noise Immunity

The input sensitivity of a standard RS-485 transceiver is  $\pm 200$  mV. When the differential input voltage, V<sub>ID</sub>, is greater than +200 mV, the receiver output turns high, for V<sub>ID</sub> < -200 mV the receiver outputs low.

The SN888C transceiver implements high receiver noise-immunity by providing a typical positive-going input threshold of 35 mV and a minimum hysteresis of 40 mV. In the case of a noisy input condition, a differential noise voltage of up to 40 mV<sub>PP</sub> can be present without causing the receiver output to change states from high to low.

#### **Transient Protection**

The bus terminals of the SN888C transceiver family possess on-chip ESD protection against ±16 kV HBM and ±12 kV IEC61000-4-2 contact discharge. The International Electrotechnical Commision (IEC) ESD test is far more severe than the HBM ESD test. The 50% higher charge capacitance,  $C_S$ , and 78% lower discharge resistance,  $R_D$  of the IEC model produce significantly higher discharge currents than the HBM model.

As stated in the IEC 61000-4-2 standard, contact discharge is the preferred transient protection test method. Although IEC air-gap testing is less repeatable than contact testing, air discharge protection levels are inferred from the contact discharge test results.

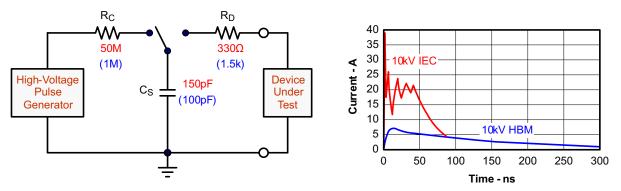


Figure 16. HBM and IEC-ESD Models and Currents in Comparison (HBM Values in Parenthesis)

#### SLLSEI4 -SEPTEMBER 2013

TEXAS INSTRUMENTS

www.ti.com

The on-chip implementation of IEC ESD protection significantly increases the robustness of equipment. Common discharge events occur because of human contact with connectors and cables. Designers may choose to implement protection against longer duration transients, typically referred to as surge transients. Figure 10 suggests two circuit designs providing protection against short and long-duration surge transients, in addition to ESD and Electrical Fast Transients (EFT) transients. Table 2 lists the bill of materials for the external protection devices.

EFTs are generally caused by relay-contact bounce, or the interruption of inductive loads. Surge transients often result from lightning strikes (direct strike or an indirect strike which induces voltages and currents), or the switching of power systems, including load changes and short circuits switching. These transients are often encountered in industrial environments, such as in factory automation and power-grid systems.

Figure 17 compares the pulse-power of the EFT and surge transients with the power caused by an IEC ESD transient. In the diagram on the left of Figure 17, the tiny blue blip in the bottom left corner represents the power of a 10-kV ESD transient, which is low compared to the significantly higher EFT power spike, and certainly lower than the 500-V surge transient. This type of transient power is well representative of factory environments in industrial and process automation. The diagram on the right of Figure 17 compares the enormous power of a 6-kV surge transient, most likely occurring in e-metering applications of power generating and power grid systems, with the aforementioned 500-V surge transient.

#### NOTE

The unit of the pulse-power changes from kW to MW, thus making the power of the 500-V surge transient almost disappear from the scale.

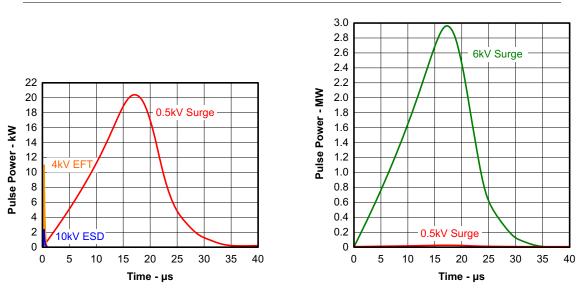


Figure 17. Power Comparison of ESD, EFT, and Surge Transients

In the case of surge transients, hgih-energy content is signified by long pulse duration and slow-decaying pulse power

The electrical energy of a transient that is dumped into the internal protection cells of the transceiver is converted into thermal energy. This thermal energy heats the protection cells and literally destroys them, thus destroying the transceiver. Figure 18 shows the large differences in transient energies for single ESD, EFT, and surge transients as well as for an EFT pulse train, commonly applied during compliance testing.



SLLSEI4 -SEPTEMBER 2013



www.ti.com

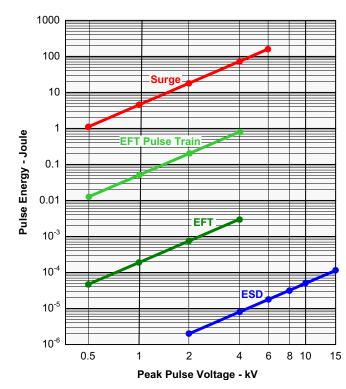


Figure 18. Comparison of Transient Energies

Table 2. Bill of Materials

Device	Function	Order Number	Manufacturer
XCVR	5-V, 250-kbps RS-485 Transceiver	SN888C	TI
R1, R2	10-Ω, Pulse-Proof Thick-Film Resistor	CRCW0603010RJNEAHP	Vishay
TVS	Bidirectional 400-W Transient Suppressor	CDSOT23-SM712	Bourns
TBU1, TBU2	Bidirectional.	TBU-CA-065-200-WH	Bourns
MOV1, MOV2	200mA Transient Blocking Unit 200-V, Metal- Oxide Varistor	MOV-10D201K	Bourns

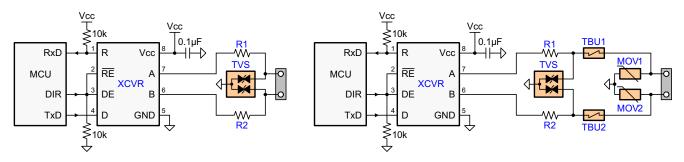


Figure 19. Transient Protections Against ESD, EFT, and Surge Transients

The left circuit shown in Figure 19 provides surge protection of  $\geq$  500-V transients, while the right protection circuits can withstand surge transients of 5 kV.

## Design and Layout Considerations for Transient Protection

Because ESD and EFT transients have a wide frequency bandwidth from approximately 3 MHz to 3 GHz, high-frequency layout techniques must be applied during PCB design.

In order for PCB design to be successful, begin with the design of the protection circuit in mind.

- 1. Place the protection circuitry close to the bus connector to prevent noise transients from penetrating your board.
- 2. Use V<sub>cc</sub> and ground planes to provide low-inductance. Note that high-frequency currents follow the path of least inductance, not the path of least impedance.
- 3. Design the protection components into the direction of the signal path. Do not force the transients currents to divert from the signal path to reach the protection device.
- 4. Apply 100-NF to 220-nF bypass capacitors as close as possible to the  $V_{CC}$ -pins of transceiver, UART, controller ICs on the board.
- 5. Use at least two vias for  $V_{CC}$  and ground connections of bypass capacitors and protection devices to minimize effective via-inductance.
- 6. Use 1-k to 10-k pull-up or pull-down resistors for enable lines to limit noise currents in these lines during transient events.
- 7. Insert pulse-proof resistors into the A and B bus lines, if the TVS clamping voltage is higher than the specified maximum voltage of the transceiver bus terminals. These resistors limit the residual clamping current into the transceiver and prevent it from latching up.
  - While pure TVS protection is sufficient for surge transients up to 1 kV, higher transients require metaloxide varistors (MOVs), which reduce the transients to a few-hundred volts of clamping voltage, and transient blocking units (TBUs) that limit transient current to 200 mA.



#### Isolated Bus Node Design

Many RS-485 networks use isolated bus nodes to prevent the creation of unintended ground loops and their disruptive impact on signal integrity. An isolated bus node typically includes a micro controller that connects to the bus transceiver through a multi-channel, digital isolator (Figure 20).

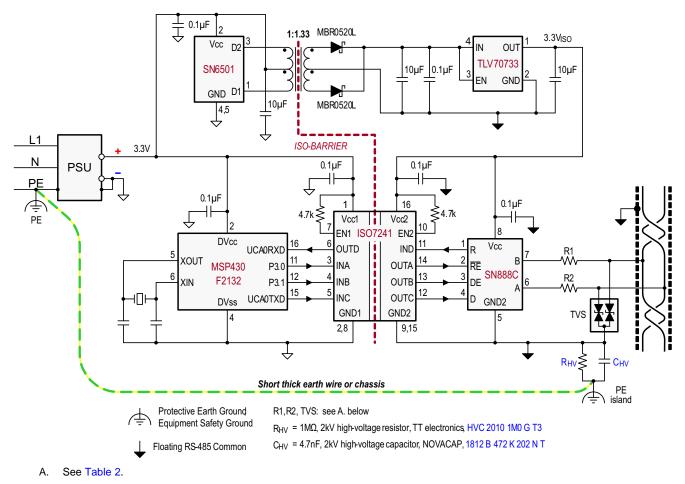


Figure 20. Isolated Bus Node With Transient Protection

Power isolation is accomplished using the push-pull transformer driver SN6501 and a low-cost LDO, TLV70733.

Signal isolation uses the quadruple digital isolator ISO7241. Notice that both enable inputs, EN1 and EN2, are pulled-up via 4.7-k resistors to limit input currents during transient events.

While the transient protection is similar to the one in Figure 19 (left circuit), an additional high-voltage capacitor diverts transient energy from the floating RS-485 common further towards protective earth (PE) ground. This diversion is necessary as noise transients on the bus are usually referred to earth potential.

R<sub>VH</sub> refers to a high-voltage resistor, and in some applications, even a varistor. This resistance is applied to prevent charging of the floating ground to dangerous potentials during normal operation.

Occasionally varistors are used instead of resistors in order to rapidly discharge  $C_{HV}$ , if expecting that fast transients might charge  $C_{HV}$  to high-potentials.

Note that the PE island represents a copper island on the PCB for the provision of a short, thick earth wire connecting this island to PE ground at the entrance of the power supply unit (PSU).

In equipment designs using a chassis, the PE connection is usually provided through the chassis itself. Typically the PE conductor is tied to the chassis at one end, while the high-voltage components,  $C_{HV}$  and  $R_{HV}$ , connect to the chassis at the other end.



### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
SN888CD	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS485N
									EESA
SN888CD.A	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS485N
									EESA
SN888CD.B	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS485N
									EESA
SN888CDR	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS485N
									EESA
SN888CDR.A	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS485N
									EESA
SN888CDR.B	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS485N
			( ) ] -						EESA

<sup>(1)</sup> **Status:** For more details on status, see our product life cycle.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.



# PACKAGE OPTION ADDENDUM

23-May-2025

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



## TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal	

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN888CDR	SOIC	D	8	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1



# PACKAGE MATERIALS INFORMATION

23-May-2025



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN888CDR	SOIC	D	8	2500	353.0	353.0	32.0

## TEXAS INSTRUMENTS

www.ti.com

23-May-2025

## TUBE



## - B - Alignment groove width

#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
SN888CD	D	SOIC	8	75	507	8	3940	4.32
SN888CD.A	D	SOIC	8	75	507	8	3940	4.32
SN888CD.B	D	SOIC	8	75	507	8	3940	4.32

# D0008A



# **PACKAGE OUTLINE**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



# D0008A

# **EXAMPLE BOARD LAYOUT**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# D0008A

# **EXAMPLE STENCIL DESIGN**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025, Texas Instruments Incorporated